

Semiconductor devices — Micro-electromechanical devices —

Part 3: Thin film standard test piece for tensile testing

The European Standard EN 62047-3:2006 has the status of a
British Standard

ICS 31.080.99

National foreword

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The UK participation in its preparation was entrusted to Technical Committee EPL/47, Semiconductors.

A list of organizations represented on EPL/47 can be obtained on request to its secretary.

This publication does not purport to include all the necessary provisions of a contract. Users are responsible for its correct application.

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